Searcn Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/521,460	CHIBA, MITSURU	
Examiner	Art Unit	
Scott Bushey	1724	

Scott Bushey

SEARCHED			
Class	Subclass	Date	Examiner
Updated	Previous	10/3/2006	CSB
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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PGPub Te	ext Search	10/3/2006	CSB

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